## Notice of References Cited

Application/Control No.

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Examiner

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Reexamination
VOUTAY ET AL.

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## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,597,994	07-2003	Meek, Robert A.	702/16
*	В	US-2004/0210394	10-2004	Trappe et al.	702/14
*	С	US-6,651,006	11-2003	Trappe et al.	702/14
*	۵	US-6,516,274	02-2003	Cheng et al.	702/14
*	Е	US-6,223,126	04-2001	Neff et al.	702/16
*	F	US-			
*	G	US-			
*	Н	US-			
*	1	US-			
*	J	US-			
*	К	US-			
*	L	US-			
*	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
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	w			
	х			

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.